

Search Notes

Application/Control No.

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Examiner

Jacob Meek

Applicant(s)/Patent under
Reexamination

AHN, KEUN HEE

Art Unit

2637

SEARCHED

Class	Subclass	Date	Examiner
375	326,341 340,348 230,232 344	6/24/2005	JM
329	304,306	6/24/2005	JM
375	344,216	6/24/2005	JM
375	321	6/24/2005	JM
331	4	6/24/2005	JM
375	329,331	6/24/2005	JM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	6/24/2005	JM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	316	6/24/2005	JM
375	229	6/24/2005	JM